

# MOS INTEGRATED CIRCUIT

## MC-4R192CPE6C

### Direct Rambus™ DRAM RIMM™ Module

#### 192M-BYTE (96M-WORD x 16-BIT)

#### Description

The Direct Rambus RIMM module is a general-purpose high-performance memory module subsystem suitable for use in a broad range of applications including computer memory, personal computers, workstations, and other applications where high bandwidth and low latency are required.

MC-4R192CPE6C modules consists of twelve 128M Direct Rambus DRAM (Direct RDRAM™) devices (μPD488448). These are extremely high-speed CMOS DRAMs organized as 8M words by 16 bits. The use of Rambus Signaling Level (RSL) technology permits 600MHz, 711MHz or 800MHz transfer rates while using conventional system and board design technologies.

Direct RDRAM devices are capable of sustained data transfers at 1.25 ns per two bytes (10 ns per sixteen bytes).

The architecture of the Direct RDRAM enables the highest sustained bandwidth for multiple, simultaneous, randomly addressed memory transactions. The separate control and data buses with independent row and column control yield over 95 % bus efficiency. The Direct RDRAM's 32 banks support up to four simultaneous transactions per device.

#### Features

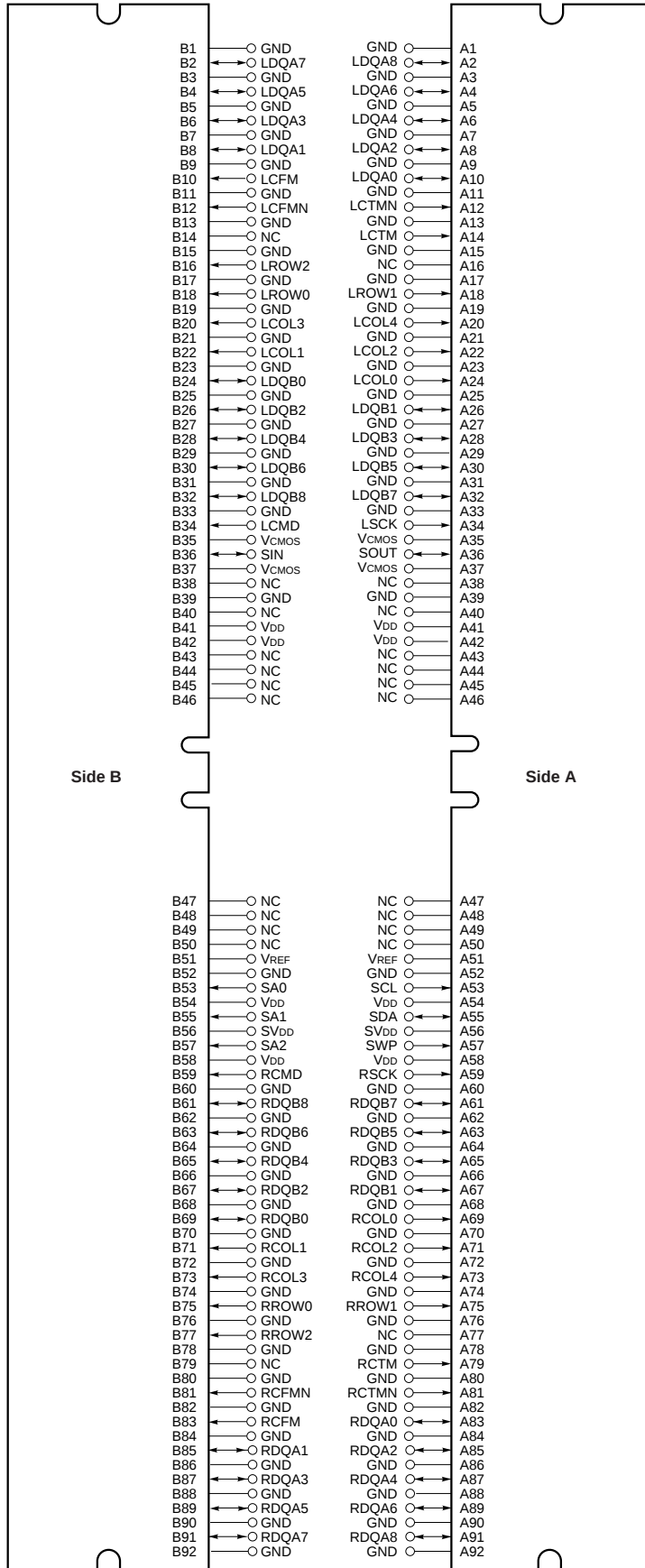
- 184 edge connector pads with 1mm pad spacing
- 192 MB Direct RDRAM storage
- Each RDRAM® has 32 banks, for 384 banks total on module
- Gold plated contacts
- RDRAMs use Chip Scale Package (CSP)
- Serial Presence Detect support
- Operates from a 2.5 V supply
- Low power and powerdown self refresh modes
- Separate Row and Column buses for higher efficiency
- Over Drive Factor (ODF) support

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version.  
Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

Order information

| Part number         | Organization | I/O Freq.<br>MHz | RAS access time<br>ns | Package                                                                            | Mounted devices                                                             |
|---------------------|--------------|------------------|-----------------------|------------------------------------------------------------------------------------|-----------------------------------------------------------------------------|
| MC-4R192CPE6C - 845 | 96M x 16     | 800              | 45                    | 184 edge connector pads RIMM<br>with heat spreader<br>Edge connector : Gold plated | 12 pieces of<br>$\mu$ PD488448FF<br>FBGA ( $\mu$ BGA <sup>®</sup> ) package |
| MC-4R192CPE6C - 745 |              | 711              | 45                    |                                                                                    |                                                                             |
| MC-4R192CPE6C - 653 |              | 600              | 53                    |                                                                                    |                                                                             |

# Module Pad Configuration



LCFM, LCFMN,  
RCFM, RCFMN : Clock from master  
LCTM, LCTMN,  
RCTM, RCTMN : Clock to master  
LCMD, RCMD : Serial Command Pad  
LROW2 - LROW0,  
RROW2 - RROW0 : Row bus  
LCOL4 - LCOL0,  
RCOL4 - RCOL0 : Column bus  
LDQA8 - LDQA0,  
RDQA8 - RDQA0 : Data bus A  
LDQB8 - LDQB0,  
RDQB8 - RDQB0 : Data bus B  
LSCK, RSCK : Clock input  
SA0 - SA2 : Serial Presence Detect Address  
SCL, SDA : Serial Presence Detect Clock  
SIN, SOUT : Serial I/O  
SVDD : SPD Voltage  
SWP : Serial Presence Detect Write Protect  
VCMOS : Supply voltage for serial pads  
VDD : Supply voltage  
VREF : Logic threshold  
GND : Ground reference  
NC : These pads are not connected

Module Pad Names

| Pad | Signal Name       | Pad | Signal Name       |
|-----|-------------------|-----|-------------------|
| A1  | GND               | B1  | GND               |
| A2  | LDQA8             | B2  | LDQA7             |
| A3  | GND               | B3  | GND               |
| A4  | LDQA6             | B4  | LDQA5             |
| A5  | GND               | B5  | GND               |
| A6  | LDQA4             | B6  | LDQA3             |
| A7  | GND               | B7  | GND               |
| A8  | LDQA2             | B8  | LDQA1             |
| A9  | GND               | B9  | GND               |
| A10 | LDQA0             | B10 | LCFM              |
| A11 | GND               | B11 | GND               |
| A12 | LCTMN             | B12 | LCFMN             |
| A13 | GND               | B13 | GND               |
| A14 | LCTM              | B14 | NC                |
| A15 | GND               | B15 | GND               |
| A16 | NC                | B16 | LROW2             |
| A17 | GND               | B17 | GND               |
| A18 | LROW1             | B18 | LROW0             |
| A19 | GND               | B19 | GND               |
| A20 | LCOL4             | B20 | LCOL3             |
| A21 | GND               | B21 | GND               |
| A22 | LCOL2             | B22 | LCOL1             |
| A23 | GND               | B23 | GND               |
| A24 | LCOL0             | B24 | LDQB0             |
| A25 | GND               | B25 | GND               |
| A26 | LDQB1             | B26 | LDQB2             |
| A27 | GND               | B27 | GND               |
| A28 | LDQB3             | B28 | LDQB4             |
| A29 | GND               | B29 | GND               |
| A30 | LDQB5             | B30 | LDQB6             |
| A31 | GND               | B31 | GND               |
| A32 | LDQB7             | B32 | LDQB8             |
| A33 | GND               | B33 | GND               |
| A34 | LSCK              | B34 | LCMD              |
| A35 | V <sub>CMOS</sub> | B35 | V <sub>CMOS</sub> |
| A36 | SOUT              | B36 | SIN               |
| A37 | V <sub>CMOS</sub> | B37 | V <sub>CMOS</sub> |
| A38 | NC                | B38 | NC                |
| A39 | GND               | B39 | GND               |
| A40 | NC                | B40 | NC                |
| A41 | V <sub>DD</sub>   | B41 | V <sub>DD</sub>   |
| A42 | V <sub>DD</sub>   | B42 | V <sub>DD</sub>   |
| A43 | NC                | B43 | NC                |
| A44 | NC                | B44 | NC                |
| A45 | NC                | B45 | NC                |
| A46 | NC                | B46 | NC                |

| Pad | Signal Name      | Pad | Signal Name      |
|-----|------------------|-----|------------------|
| A47 | NC               | B47 | NC               |
| A48 | NC               | B48 | NC               |
| A49 | NC               | B49 | NC               |
| A50 | NC               | B50 | NC               |
| A51 | V <sub>REF</sub> | B51 | V <sub>REF</sub> |
| A52 | GND              | B52 | GND              |
| A53 | SCL              | B53 | SA0              |
| A54 | V <sub>DD</sub>  | B54 | V <sub>DD</sub>  |
| A55 | SDA              | B55 | SA1              |
| A56 | SV <sub>DD</sub> | B56 | SV <sub>DD</sub> |
| A57 | SWP              | B57 | SA2              |
| A58 | V <sub>DD</sub>  | B58 | V <sub>DD</sub>  |
| A59 | RSCK             | B59 | RCMD             |
| A60 | GND              | B60 | GND              |
| A61 | RDQB7            | B61 | RDQB8            |
| A62 | GND              | B62 | GND              |
| A63 | RDQB5            | B63 | RDQB6            |
| A64 | GND              | B64 | GND              |
| A65 | RDQB3            | B65 | RDQB4            |
| A66 | GND              | B66 | GND              |
| A67 | RDQB1            | B67 | RDQB2            |
| A68 | GND              | B68 | GND              |
| A69 | RCOL0            | B69 | RDQB0            |
| A70 | GND              | B70 | GND              |
| A71 | RCOL2            | B71 | RCOL1            |
| A72 | GND              | B72 | GND              |
| A73 | RCOL4            | B73 | RCOL3            |
| A74 | GND              | B74 | GND              |
| A75 | RROW1            | B75 | RROW0            |
| A76 | GND              | B76 | GND              |
| A77 | NC               | B77 | RROW2            |
| A78 | GND              | B78 | GND              |
| A79 | RCTM             | B79 | NC               |
| A80 | GND              | B80 | GND              |
| A81 | RCTMN            | B81 | RCFMN            |
| A82 | GND              | B82 | GND              |
| A83 | RDQA0            | B83 | RCFM             |
| A84 | GND              | B84 | GND              |
| A85 | RDQA2            | B85 | RDQA1            |
| A86 | GND              | B86 | GND              |
| A87 | RDQA4            | B87 | RDQA3            |
| A88 | GND              | B88 | GND              |
| A89 | RDQA6            | B89 | RDQA5            |
| A90 | GND              | B90 | GND              |
| A91 | RDQA8            | B91 | RDQA7            |
| A92 | GND              | B92 | GND              |

## Module Connector Pad Description

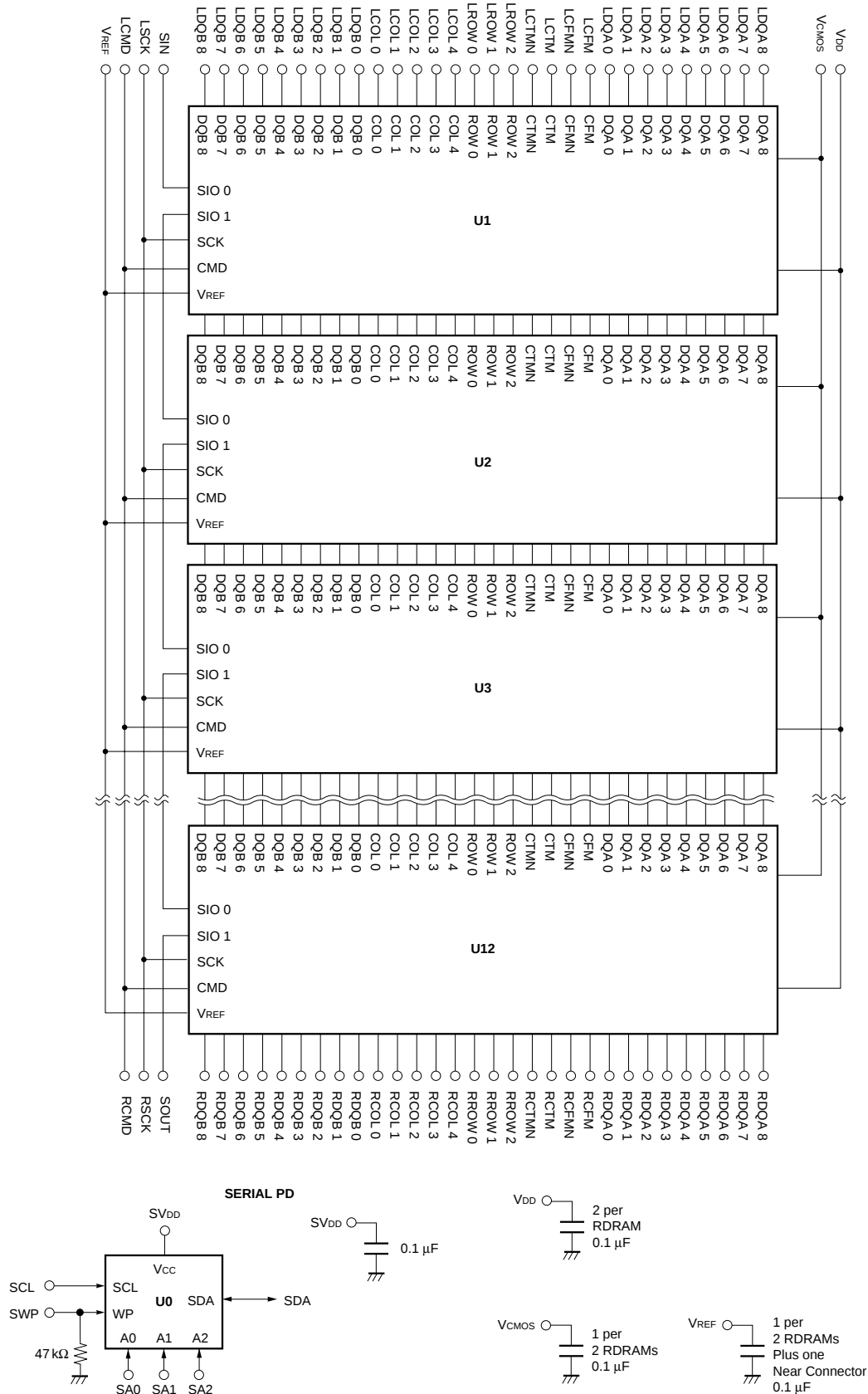
(1/2)

| Signal       | I/O | Type  | Description                                                                                                                                                 |
|--------------|-----|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------|
| GND          | —   | —     | Ground reference for RDRAM core and interface. 72 PCB connector pads.                                                                                       |
| LCFM         | I   | RSL   | Clock from master. Interface clock used for receiving RSL signals from the Channel. Positive polarity.                                                      |
| LCFMN        | I   | RSL   | Clock from master. Interface clock used for receiving RSL signals from the Channel. Negative polarity.                                                      |
| LCMD         | I   | VCMOS | Serial Command used to read from and write to the control registers. Also used for power management.                                                        |
| LCOL4..LCOL0 | I   | RSL   | Column bus. 5-bit bus containing control and address information for column accesses.                                                                       |
| LCTM         | I   | RSL   | Clock to master. Interface clock used for transmitting RSL signals to the Channel. Positive polarity.                                                       |
| LCTMN        | I   | RSL   | Clock to master. Interface clock used for transmitting RSL signals to the Channel. Negative polarity.                                                       |
| LDQA8..LDQA0 | I/O | RSL   | Data bus A. A 9-bit bus carrying a byte of read or write data between the Channel and the RDRAM. LDQA8 is non-functional on modules with x16 RDRAM devices. |
| LDQB8..LDQB0 | I/O | RSL   | Data bus B. A 9-bit bus carrying a byte of read or write data between the Channel and the RDRAM. LDQB8 is non-functional on modules with x16 RDRAM devices. |
| LROW2..LROW0 | I   | RSL   | Row bus. 3-bit bus containing control and address information for row accesses.                                                                             |
| LSCK         | I   | VCMOS | Serial clock input. Clock source used to read from and write to the RDRAM control registers.                                                                |
| NC           | —   | —     | These pads are not connected. These 24 connector pads are reserved for future use.                                                                          |
| RCFM         | I   | RSL   | Clock from master. Interface clock used for receiving RSL signals from the Channel. Positive polarity.                                                      |
| RCFMN        | I   | RSL   | Clock from master. Interface clock used for receiving RSL signals from the Channel. Negative polarity.                                                      |
| RCMD         | I   | VCMOS | Serial Command Input used to read from and write to the control registers. Also used for power management.                                                  |
| RCOL4..RCOL0 | I   | RSL   | Column bus. 5-bit bus containing control and address information for column accesses.                                                                       |
| RCTM         | I   | RSL   | Clock to master. Interface clock used for transmitting RSL signals to the Channel. Positive polarity.                                                       |
| RCTMN        | I   | RSL   | Clock to master. Interface clock used for transmitting RSL signals to the Channel. Negative polarity.                                                       |
| RDQA8..RDQA0 | I/O | RSL   | Data bus A. A 9-bit bus carrying a byte of read or write data between the Channel and the RDRAM. RDQA8 is non-functional on modules with x16 RDRAM devices. |
| RDQB8..RDQB0 | I/O | RSL   | Data bus B. A 9-bit bus carrying a byte of read or write data between the Channel and the RDRAM. RDQB8 is non-functional on modules with x16 RDRAM devices. |
| RROW2..RROW0 | I   | RSL   | Row bus. 3-bit bus containing control and address information for row accesses.                                                                             |

(2/2)

| Signal            | I/O | Type              | Description                                                                                                          |
|-------------------|-----|-------------------|----------------------------------------------------------------------------------------------------------------------|
| RSCK              | I   | V <sub>CMOS</sub> | Serial clock input. Clock source used to read from and write to the RDRAM control registers.                         |
| SA0               | I   | SV <sub>DD</sub>  | Serial Presence Detect Address 0.                                                                                    |
| SA1               | I   | SV <sub>DD</sub>  | Serial Presence Detect Address 1.                                                                                    |
| SA2               | I   | SV <sub>DD</sub>  | Serial Presence Detect Address 2.                                                                                    |
| SCL               | I   | SV <sub>DD</sub>  | Serial Presence Detect Clock.                                                                                        |
| SDA               | I/O | SV <sub>DD</sub>  | Serial Presence Detect Data (Open Collector I/O).                                                                    |
| SIN               | I/O | V <sub>CMOS</sub> | Serial I/O for reading from and writing to the control registers. Attaches to SIO0 of the first RDRAM on the module. |
| SOUT              | I/O | V <sub>CMOS</sub> | Serial I/O for reading from and writing to the control registers. Attaches to SIO1 of the last RDRAM on the module.  |
| SV <sub>DD</sub>  | —   | —                 | SPD Voltage. Used for signals SCL, SDA, SWP, SA0, SA1 and SA2.                                                       |
| SWP               | I   | SV <sub>DD</sub>  | Serial Presence Detect Write Protect (active high). When low, the SPD can be written as well as read.                |
| V <sub>CMOS</sub> | —   | —                 | CMOS I/O Voltage. Used for signals CMD, SCK, SIN, SOUT.                                                              |
| V <sub>DD</sub>   | —   | —                 | Supply voltage for the RDRAM core and interface logic.                                                               |
| V <sub>REF</sub>  | —   | —                 | Logic threshold reference voltage for RSL signals.                                                                   |

## Block Diagram



- Remarks**
1. Rambus Channel signals form a loop through the RIMM module, with the exception of the SIO chain.
  2. See Serial Presence Detection Specification for information on the SPD device and its contents.

## Electrical Specification

### Absolute Maximum Ratings

| Symbol       | Parameter                                                         | MIN. | MAX.           | Unit |
|--------------|-------------------------------------------------------------------|------|----------------|------|
| $V_{I,ABS}$  | Voltage applied to any RSL or CMOS signal pad with respect to GND | -0.3 | $V_{DD} + 0.3$ | V    |
| $V_{DD,ABS}$ | Voltage on $V_{DD}$ with respect to GND                           | -0.5 | $V_{DD} + 1.0$ | V    |
| $T_{STORE}$  | Storage temperature                                               | -50  | +100           | °C   |

**Caution** Exposing the device to stress above those listed in Absolute Maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

### DC Recommended Electrical Conditions

| Symbol         | Parameter and conditions                                      |                  | MIN.                 | MAX.                 | Unit |
|----------------|---------------------------------------------------------------|------------------|----------------------|----------------------|------|
| $V_{DD}$       | Supply voltage                                                |                  | 2.50 – 0.13          | 2.50 + 0.13          | V    |
| $V_{CMOS}$     | CMOS I/O power supply at pad                                  | 2.5V controllers | 2.5 – 0.13           | 2.5 + 0.25           | V    |
|                |                                                               | 1.8V controllers | 1.8 – 0.1            | 1.8 + 0.2            |      |
| $V_{REF}$      | Reference voltage                                             |                  | 1.4 – 0.2            | 1.4 + 0.2            | V    |
| $V_{IL}$       | RSL input low voltage                                         |                  | $V_{REF} - 0.5$      | $V_{REF} - 0.2$      | V    |
| $V_{IH}$       | RSL input high voltage                                        |                  | $V_{REF} + 0.2$      | $V_{REF} + 0.5$      | V    |
| $V_{IL,CMOS}$  | CMOS input low voltage                                        |                  | -0.3                 | $0.5V_{CMOS} - 0.25$ | V    |
| $V_{IH,CMOS}$  | CMOS input high voltage                                       |                  | $0.5V_{CMOS} + 0.25$ | $V_{CMOS} + 0.3$     | V    |
| $V_{OL,CMOS}$  | CMOS output low voltage, $I_{OL,CMOS} = 1\text{ mA}$          |                  | —                    | 0.3                  | V    |
| $V_{OH,CMOS}$  | CMOS output high voltage, $I_{OH,CMOS} = -0.25\text{ mA}$     |                  | $V_{CMOS} - 0.3$     | —                    | V    |
| $I_{REF}$      | $V_{REF}$ current, $V_{REF,MAX}$                              |                  | -120.0               | +120.0               | μA   |
| $I_{SCK,CMD}$  | CMOS input leakage current, ( $0 \leq V_{CMOS} \leq V_{DD}$ ) |                  | -120.0               | +120.0               | μA   |
| $I_{SIN,SOUT}$ | CMOS input leakage current, ( $0 \leq V_{CMOS} \leq V_{DD}$ ) |                  | -10.0                | +10.0                | μA   |

### AC Electrical Specifications

★

| Symbol                           | Parameter and Conditions                                                                                   |      | MIN. | TYP. | MAX. | Unit |
|----------------------------------|------------------------------------------------------------------------------------------------------------|------|------|------|------|------|
| Z                                | Module Impedance                                                                                           |      | 25.2 | 28   | 30.8 | Ω    |
| T <sub>PD</sub>                  | Average clock delay from finger to finger of all RSL clock nets (CTM, CTMN, CFM, and CFMN)                 | -845 |      |      | 1.76 | ns   |
|                                  |                                                                                                            | -745 |      |      | 1.76 |      |
|                                  |                                                                                                            | -653 |      |      | 1.76 |      |
| ΔT <sub>PD</sub>                 | Propagation delay variation of RSL signals with respect to T <sub>PD</sub> <sup>Note1,2</sup>              |      | -21  |      | +21  | ps   |
| ΔT <sub>PD-CMOS</sub>            | Propagation delay variation of SCK and CMD signals with respect to an average clock delay <sup>Note1</sup> |      | -100 |      | +100 | ps   |
| V <sub>o</sub> /V <sub>IN</sub>  | Attenuation Limit                                                                                          | -845 |      |      | 20   | %    |
|                                  |                                                                                                            | -745 |      |      | 20   |      |
|                                  |                                                                                                            | -653 |      |      | 18   |      |
| V <sub>XF</sub> /V <sub>IN</sub> | Forward crosstalk coefficient (300ps input rise time 20% - 80%)                                            | -845 |      |      | 6    | %    |
|                                  |                                                                                                            | -745 |      |      | 6    |      |
|                                  |                                                                                                            | -653 |      |      | 6    |      |
| V <sub>XB</sub> /V <sub>IN</sub> | Backward crosstalk coefficient (300ps input rise time 20% - 80%)                                           | -845 |      |      | 2.3  | %    |
|                                  |                                                                                                            | -745 |      |      | 2.3  |      |
|                                  |                                                                                                            | -653 |      |      | 2.3  |      |
| R <sub>DC</sub>                  | DC Resistance Limit                                                                                        | -845 |      |      | 1.1  | Ω    |
|                                  |                                                                                                            | -745 |      |      | 1.1  |      |
|                                  |                                                                                                            | -653 |      |      | 1.1  |      |

- Notes**
1. T<sub>PD</sub> or Average clock delay is defined as the average delay from finger to finger of all RSL clock nets (CTM, CTMN, CFM, and CFMN).
  2. If the RIMM module meets the following specification, then it is compliant to the specification.  
If the RIMM module does not meet these specifications, then the specification can be adjusted by the "Adjusted ΔT<sub>PD</sub> Specification" table.

### Adjusted ΔT<sub>PD</sub> Specification

| Symbol           | Parameter and conditions                                                   | Adjusted MIN./MAX.                  | Absolute |      | Unit |
|------------------|----------------------------------------------------------------------------|-------------------------------------|----------|------|------|
|                  |                                                                            |                                     | MIN.     | MAX. |      |
| ΔT <sub>PD</sub> | Propagation delay variation of RSL signals with respect to T <sub>PD</sub> | +/- [20+(18*N*ΔZ0)] <sup>Note</sup> | -40      | +40  | ps   |

**Note** N = Number of RDRAM devices installed on the RIMM module.

$$\Delta Z0 = \text{delta } Z0\% = (\text{MAX. } Z0 - \text{MIN. } Z0) / (\text{MIN. } Z0)$$

(MAX. Z0 and MIN. Z0 are obtained from the loaded (high impedance) impedance coupons of all RSL layers on the module.)

# RIMM Module Current Profile

| I <sub>DD</sub>  | RIMM module power conditions <sup>Note1</sup>                |      | MAX.  | Unit |
|------------------|--------------------------------------------------------------|------|-------|------|
| I <sub>DD1</sub> | One RDRAM in Read <sup>Note2</sup> , balance in NAP mode     | -845 | 736.2 | mA   |
|                  |                                                              | -745 | 671.2 |      |
|                  |                                                              | -653 | 586.2 |      |
| I <sub>DD2</sub> | One RDRAM in Read <sup>Note2</sup> , balance in Standby mode | -845 | 1,900 | mA   |
|                  |                                                              | -745 | 1,780 |      |
|                  |                                                              | -653 | 1,585 |      |
| I <sub>DD3</sub> | One RDRAM in Read <sup>Note2</sup> , balance in Active mode  | -845 | 2,670 | mA   |
|                  |                                                              | -745 | 2,440 |      |
|                  |                                                              | -653 | 2,135 |      |
| I <sub>DD4</sub> | One RDRAM in Write, balance in NAP mode                      | -845 | 696.2 | mA   |
|                  |                                                              | -745 | 641.2 |      |
|                  |                                                              | -653 | 561.2 |      |
| I <sub>DD5</sub> | One RDRAM in Write, balance in Standby mode                  | -845 | 1,860 | mA   |
|                  |                                                              | -745 | 1,750 |      |
|                  |                                                              | -653 | 1,560 |      |
| I <sub>DD6</sub> | One RDRAM in Write, balance in Active mode                   | -845 | 2,630 | mA   |
|                  |                                                              | -745 | 2,410 |      |
|                  |                                                              | -653 | 2,110 |      |

**Notes 1.** Actual power will depend on individual RDRAM component specifications, memory controller and usage patterns. Power does not include Refresh Current.

- I/O current is a function of the % of 1's, to add I/O power for 50 % 1's for a x16 need to add 257 mA for the following : V<sub>DD</sub> = 2.5 V, V<sub>TERM</sub> = 1.8 V, V<sub>REF</sub> = 1.4 V and V<sub>DIL</sub> = V<sub>REF</sub> – 0.5 V.

## Timing Parameters

The following timing parameters are from the RDRAMs pins, not the RIMM. Please refer to the RDRAM data sheet ( $\mu$ PD488448) for detailed timing diagrams.

| Parameter    | Description                                                                                                                                                                                                                                                                                                         | MIN. |      |      | MAX.               | Units       |
|--------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|------|--------------------|-------------|
|              |                                                                                                                                                                                                                                                                                                                     | -845 | -745 | -653 |                    |             |
| $t_{RC}$     | Row Cycle time of RDRAM banks - the interval between ROWA packets with ACT commands to the same bank.                                                                                                                                                                                                               | 28   | 28   | 28   | —                  | $t_{CYCLE}$ |
| $t_{RAS}$    | RAS-asserted time of RDRAM bank - the interval between ROWA packet with ACT command and next ROWR packet with $PRER^{Note 1}$ command to the same bank.                                                                                                                                                             | 20   | 20   | 20   | $64\mu s^{Note 2}$ | $t_{CYCLE}$ |
| $t_{RP}$     | Row Precharge time of RDRAM banks - the interval between ROWR packet with $PRER^{Note 1}$ command and next ROWA packet with ACT command to the same bank.                                                                                                                                                           | 8    | 8    | 8    | —                  | $t_{CYCLE}$ |
| $t_{PP}$     | Precharge-to-precharge time of RDRAM device - the interval between successive ROWR packets with $PRER^{Note 1}$ commands to any banks of the same device.                                                                                                                                                           | 8    | 8    | 8    | —                  | $t_{CYCLE}$ |
| $t_{RR}$     | RAS-to-RAS time of RDRAM device - the interval between successive ROWA packets with ACT commands to any banks of the same device.                                                                                                                                                                                   | 8    | 8    | 8    | —                  | $t_{CYCLE}$ |
| $t_{RCD}$    | RAS-to-CAS Delay - the interval from ROWA packet with ACT command to COLC packet with RD or WR command. Note - the RAS-to-CAS delay seen by the RDRAM core ( $t_{RCD-C}$ ) is equal to $t_{RCD-C} = 1 + t_{RCD}$ because of differences in the row and column paths through the RDRAM interface.                    | 9    | 7    | 7    | —                  | $t_{CYCLE}$ |
| $t_{CAC}$    | CAS Access delay - the interval from RD command to Q read data. The equation for $t_{CAC}$ is given in the TPARM register.                                                                                                                                                                                          | 8    | 8    | 8    | 12                 | $t_{CYCLE}$ |
| $t_{CWD}$    | CAS Write Delay - interval from WR command to D write data.                                                                                                                                                                                                                                                         | 6    | 6    | 6    | 6                  | $t_{CYCLE}$ |
| $t_{CC}$     | CAS-to-CAS time of RDRAM bank - the interval between successive COLC commands.                                                                                                                                                                                                                                      | 4    | 4    | 4    | —                  | $t_{CYCLE}$ |
| $t_{PACKET}$ | Length of ROWA, ROWR, COLC, COLM or COLX packet.                                                                                                                                                                                                                                                                    | 4    | 4    | 4    | 4                  | $t_{CYCLE}$ |
| $t_{RTR}$    | Interval from COLC packet with WR command to COLC packet which causes retire, and to COLM packet with bytemask.                                                                                                                                                                                                     | 8    | 8    | 8    | —                  | $t_{CYCLE}$ |
| $t_{OFFP}$   | The interval (offset) from COLC packet with RDA command, or from COLC packet with retire command (after WRA automatic precharge), or from COLC packet with PREC command, or from COLX packet with PREX command to the equivalent ROWR packet with PRER. The equation for $t_{OFFP}$ is given in the TPARM register. | 4    | 4    | 4    | 4                  | $t_{CYCLE}$ |
| $t_{RDP}$    | Interval from last COLC packet with RD command to ROWR packet with PRER.                                                                                                                                                                                                                                            | 4    | 4    | 4    | —                  | $t_{CYCLE}$ |
| $t_{RTP}$    | Interval from last COLC packet with automatic retire command to ROWR packet with PRER.                                                                                                                                                                                                                              | 4    | 4    | 4    | —                  | $t_{CYCLE}$ |

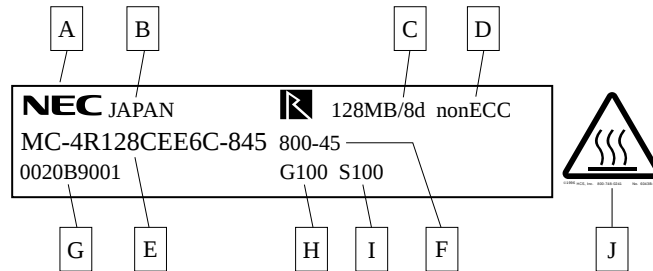
**Notes** 1. Or equivalent PREC or PREX command.

2. This is a constraint imposed by the core, and is therefore in units of ms rather than  $t_{CYCLE}$ .

## ★ Standard RIMM Module Marking

The RIMM modules available from NEC are marked per Figure 1 below. This marking assists users to specify and verify if the correct RIMM modules are installed in their systems. In the diagram, a label is shown attached to the RIMM module's heat spreader. Information contained on the label is specific to the RIMM module and provides RDRAM information without requiring removal of the RIMM module's heat spreader.

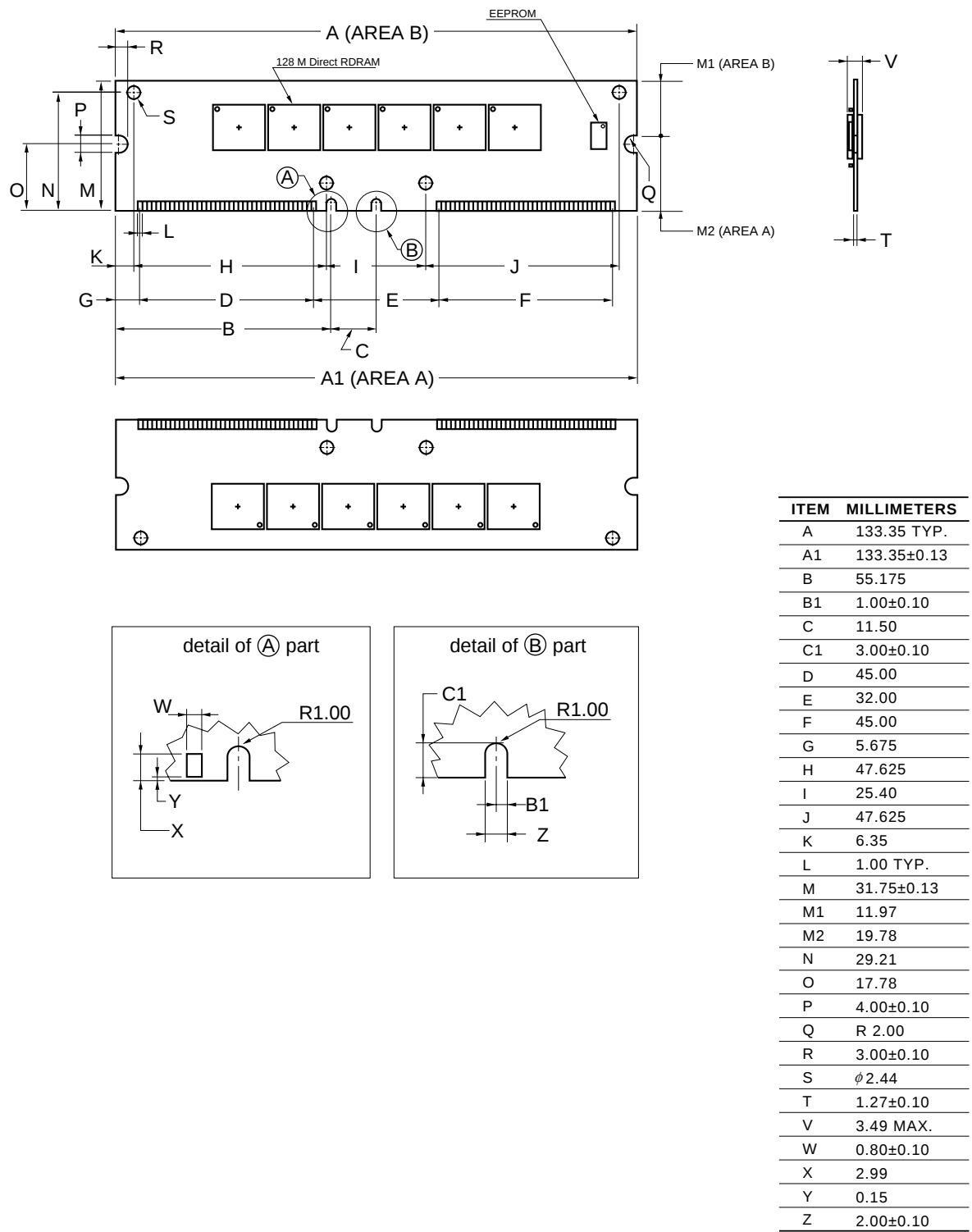
**Figure 1. RIMM Module marking example**



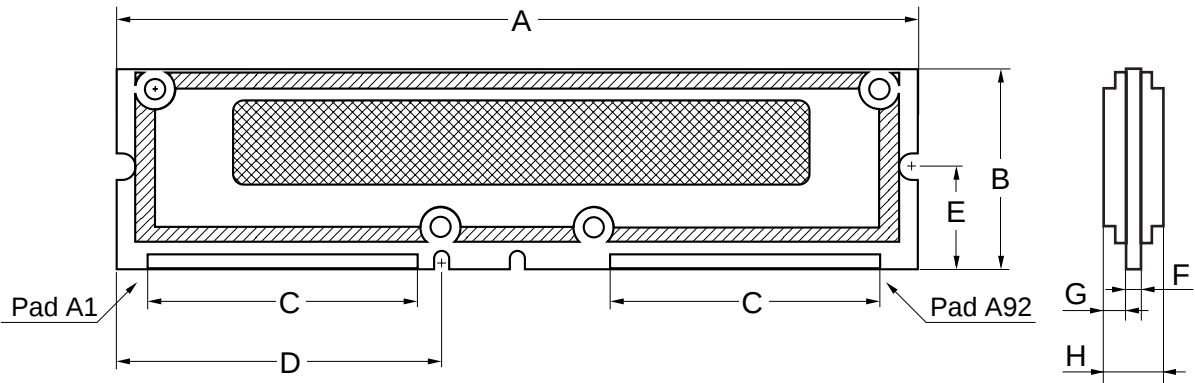
| Label Field |                        | Description                                                                     | Marked Text                        | Units         |
|-------------|------------------------|---------------------------------------------------------------------------------|------------------------------------|---------------|
| A           | Vendor logo            | Vendor logo area                                                                | NEC                                | –             |
| B           | Manufacturing Country  | Country of origin                                                               | JAPAN, USA, FRANCE                 | –             |
| C           | Module Memory Capacity | Number of 8-bit or 9-bit MBytes of RDRAM storage in RIMM module                 | 64MB, 96MB, 128MB, 192MB, 256MB    | MBytes        |
|             | Number of RDRAMs       | Number of RDRAM devices contained in the RIMM module                            | /4d, /6d, /8d, /12d, /16d          | RDRAM devices |
| D           | ECC Support            | Indicates whether the RIMM module supports 8-bit (non ECC) or 9-bit (ECC) Bytes | non ECC, ECC                       | –             |
| E           | Part No.               | NEC RIMM Part No.                                                               | See table <b>Order information</b> | –             |
| F           | Memory Speed           | Data transfer speed for RIMM module                                             | 800, 711, 600                      | MHz           |
|             | t <sub>RAC</sub>       | Row Access Time                                                                 | -45, -53                           | ns            |
| G           | Manufacturing Lot No.  | Manufactured Year code, Week code, In-house code                                | YYWW*****                          | –             |
| H           | Gerber Version         | PCB Gerber file revision used on RIMM Module                                    | G100 as Rev 1.00                   | –             |
| I           | SPD Version            | SPD code version                                                                | S100 as Rev 1.00                   | –             |
| J           | Caution Logo           | –                                                                               | –                                  | –             |

Package Drawings

184 EDGE CONNECTOR PADS RIMM (SOCKET TYPE) (1/2)



184 EDGE CONNECTOR PADS RIMM (SOCKET TYPE) (2/2)



| ITEM | DESCRIPTION                                                                      | MIN.   | TYP.   | MAX.   | UNIT |
|------|----------------------------------------------------------------------------------|--------|--------|--------|------|
| A    | PCB length                                                                       | 133.22 | 133.35 | 133.48 | mm   |
| B    | PCB height for 1.25" RIMM Module                                                 | 31.62  | 31.75  | 31.88  | mm   |
| C    | Center-center pad width from pad A1 to A46, A47 to A92, B1 to B46 or B47 to B92  | 44.95  | 45.00  | 45.05  | mm   |
| D    | Spacing from PCB left edge to connector key notch                                | -      | 55.175 | -      | mm   |
| E    | Spacing from contact pad PCB edge to side edge retainer notch                    | -      | 17.78  | -      | mm   |
| F    | PCB thickness                                                                    | 1.17   | 1.27   | 1.37   | mm   |
| G    | Heat spreader thickness from PCB surface (one side) to heat spreader top surface | -      | -      | 3.09   | mm   |
| H    | RIMM thickness                                                                   | -      | -      | 7.55   | mm   |

## NOTES FOR CMOS DEVICES

### ① PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

Note:

Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

### ② HANDLING OF UNUSED INPUT PINS FOR CMOS

Note:

No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to  $V_{DD}$  or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

### ③ STATUS BEFORE INITIALIZATION OF MOS DEVICES

Note:

Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

Rambus, RDRAM and the Rambus Logo are registered trademarks of Rambus Inc.

DirectRambus, DirectRDRAM, RIMM, RModule and RSocket are trademarks of Rambus Inc.

µBGA is a registered trademark of Tessera Inc.

## CAUTION FOR HANDLING MEMORY MODULES

When handling or inserting memory modules, be sure not to touch any components on the modules, such as the memory IC, chip capacitors and chip resistors. It is necessary to avoid undue mechanical stress on these components to prevent damaging them.

When re-packing memory modules, be sure the modules are NOT touching each other. Modules in contact with other modules may cause excessive mechanical stress, which may damage the modules.

- The information in this document is current as of August, 2000. The information is subject to change without notice. For actual design-in, refer to the latest publications of NEC's data sheets or data books, etc., for the most up-to-date specifications of NEC semiconductor products. Not all products and/or types are available in every country. Please check with an NEC sales representative for availability and additional information.
- No part of this document may be copied or reproduced in any form or by any means without prior written consent of NEC. NEC assumes no responsibility for any errors that may appear in this document.
- NEC does not assume any liability for infringement of patents, copyrights or other intellectual property rights of third parties by or arising from the use of NEC semiconductor products listed in this document or any other liability arising from the use of such products. No license, express, implied or otherwise, is granted under any patents, copyrights or other intellectual property rights of NEC or others.
- Descriptions of circuits, software and other related information in this document are provided for illustrative purposes in semiconductor product operation and application examples. The incorporation of these circuits, software and information in the design of customer's equipment shall be done under the full responsibility of customer. NEC assumes no responsibility for any losses incurred by customers or third parties arising from the use of these circuits, software and information.
- While NEC endeavours to enhance the quality, reliability and safety of NEC semiconductor products, customers agree and acknowledge that the possibility of defects thereof cannot be eliminated entirely. To minimize risks of damage to property or injury (including death) to persons arising from defects in NEC semiconductor products, customers must incorporate sufficient safety measures in their design, such as redundancy, fire-containment, and anti-failure features.
- NEC semiconductor products are classified into the following three quality grades:  
 "Standard", "Special" and "Specific". The "Specific" quality grade applies only to semiconductor products developed based on a customer-designated "quality assurance program" for a specific application. The recommended applications of a semiconductor product depend on its quality grade, as indicated below. Customers must check the quality grade of each semiconductor product before using it in a particular application.  
 "Standard": Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots  
 "Special": Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)  
 "Specific": Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems and medical equipment for life support, etc.  
 The quality grade of NEC semiconductor products is "Standard" unless otherwise expressly specified in NEC's data sheets or data books, etc. If customers wish to use NEC semiconductor products in applications not intended by NEC, they must contact an NEC sales representative in advance to determine NEC's willingness to support a given application.  
 (Note)  
 (1) "NEC" as used in this statement means NEC Corporation and also includes its majority-owned subsidiaries.  
 (2) "NEC semiconductor products" means any semiconductor product developed or manufactured by or for NEC (as defined above).